![SUNX logo]
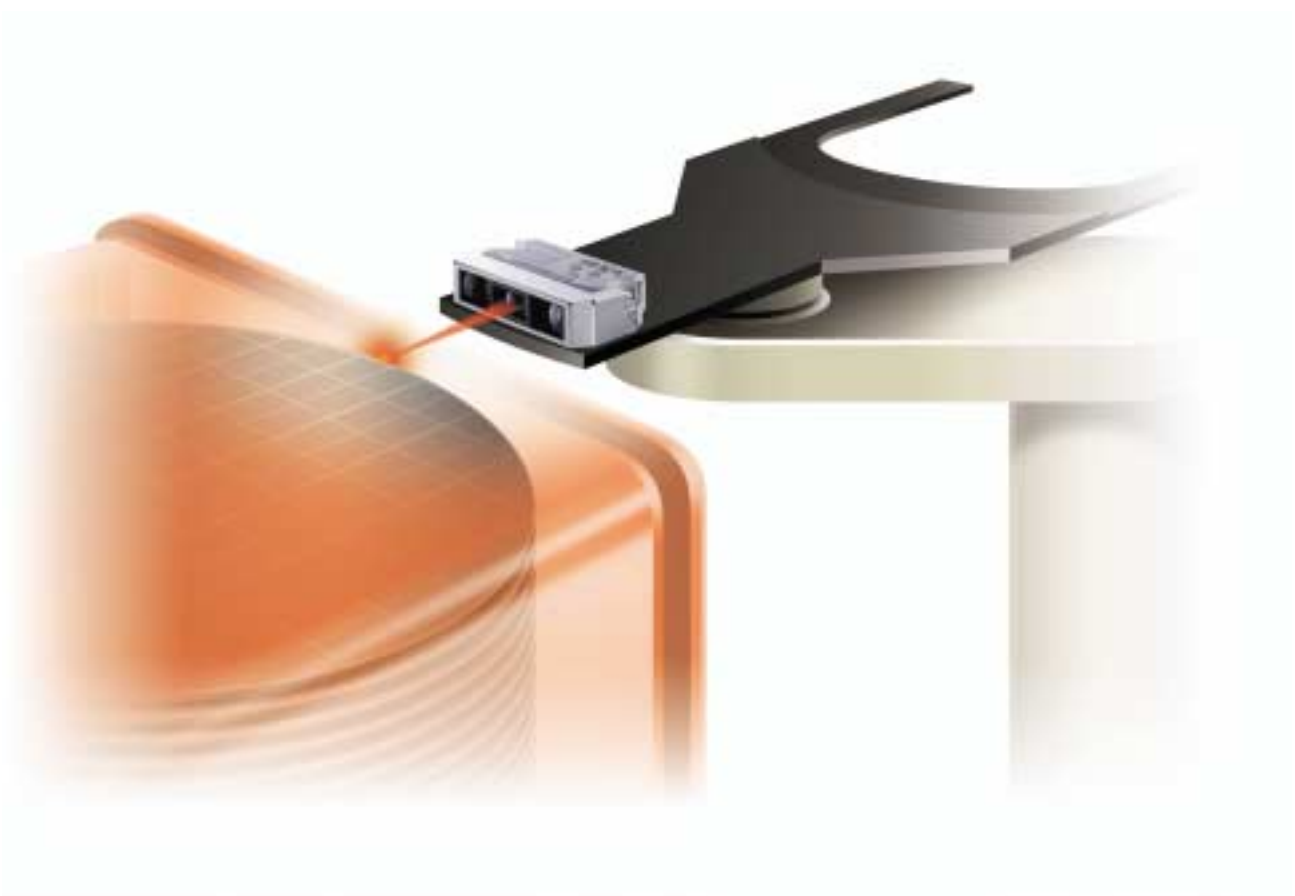
New # M-DW1

CE
Conforming to
EMC Directive

UL
UL Recognition

Sensable nitride-coated wafers

Meet the new industry standard for wafer sensing.
LED beam reflective type sensor allows you to see the red spot.

The industry-first 'LED reflective type sensor' sets the new standard for new-age mapping sensors.

For more safety and more sensing accuracy, we studied the requirements for the future wafer mapping sensor from various aspects. Our answer is the LED beam reflective type wafer mapping sensor M-DW1. This sensor uses LEDs as a light source for safe operation, and 2-segment receiving element for more accurate position detection.

All new mapping sensor, proving safety, detection ability, and ease of use

Safe LEDs Adopted

Laser mapping sensor is dangerous, because when mapping from inside the loading port, the laser beam which misses the FOUP is directed toward the operator. The **M-DW1** which uses a LED light source is much safer than the conventional laser beam mapping sensor.

Sensing of Nitride-coated Wafers Possible

Nitride-coated wafers absorb light at certain wavelengths depending on the coating thickness.
If the sensor uses the laser beam having a single wavelength, the beam may be absorbed completely, resulting in wafer detection error. The **M-DW1** uses an LED light source having a wavelength band, so that it can always detect nitride-coated wafers successfully.

Industry-first

LED beam   laser beam

LED beam mapping sensor   Laser beam mapping sensor
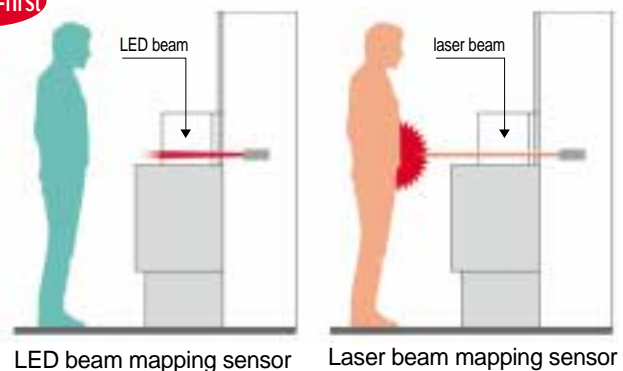
# Various features for enabling quick, accurate, and secure position detection

Precise Position Detection by 2-segment Receiving Element

Wafer detection by the amount of reflected light may sometimes fail depending on the wafer edge shape. The **M-DW1** uses 2-segment receiving element in the beam-receiving part, and detects wafers by the reflected light position instead of the amount of reflected light. Thus, the sensor is less affected by wafer thickness or the amount of reflected light.
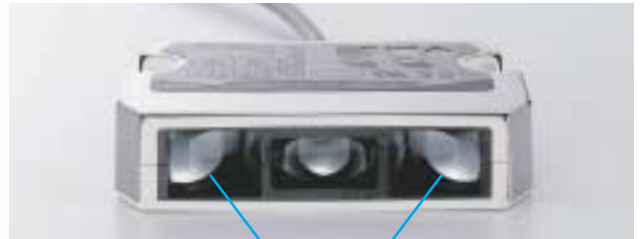
■ 2-segment receiving element

Reflected light

Element A

Element B
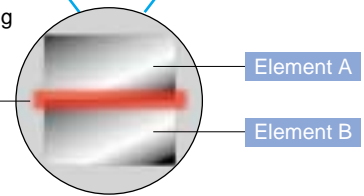
Glass Wafers Are Also Detectable

Recent trend shows a rapid increase of glass wafers. These wafers do not reflect much light and, therefore, their edge detection has been considered to be difficult. The **M-DW1**, which detects wafers not by the light amount but by the light position, can detect the glass wafers regardless of the light amount.

Glass wafer

Penetrated light

Light emission

Reflected light
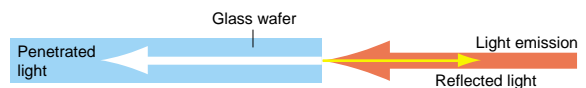
High-speed Response Time: 0.5ms

The sensor responds in 0.5ms, meeting the requirements of both high speed and high accuracy in wafer detection.

Flexible application according to your needs

Compact and Lightweight Design with Built-in Amplifier

The sensor measures 80.6mm (W) × 18.3 mm (H) × 50mm (D), and weighs only 75g.

50mm

18.3mm

80.6mm
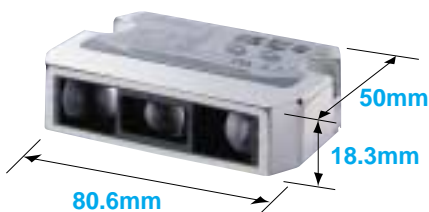
4-way Cable Direction

The sensor cable can be drawn in any of the four directions; rearward, rightward, leftward and downward. This provides more flexibility in installation of the sensor.

Global Use

The sensor is designed in compliance with CE marking EMC Directive, and obtains UL Recognition. In addition, the function for switching output method between NPN and PNP further makes the sensor usable all over the world.
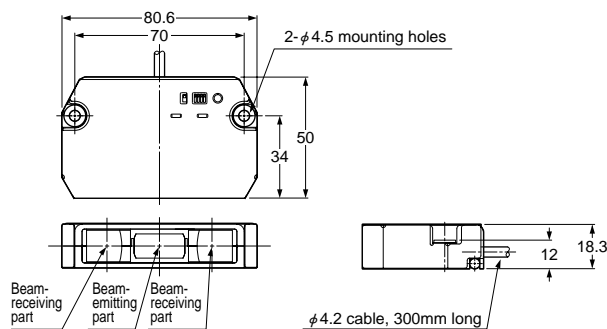
C E
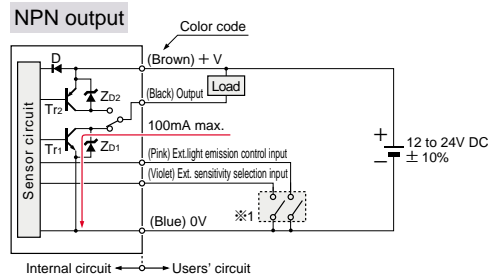Conforming to EMC Directive

UL
UL Recognition

SPECIFICATIONS

Item	Designation	LED beam reflective type wafer mapping sensor
	Model No.	**M-DW1**
Center measuring distance		45mm
Sensing object		3 inch or larger semiconductor wafer (Note 1)
Detectable surface		Surface having a side edge which reflects light in the light receiving direction (Note 2)
Sensing angle		12.5 ± 5°
Wafer pitch		Separate sensing is possible at normal sensitivity for 3mm pitch or more
Suitable cassette		SEMI standard FOUP cassette / open cassette
Supply voltage		12 to 24V DC ± 10% Ripple P-P 10% or less
Current consumption		65mA or less

Output		NPN output / PNP output, selectable with output selection switch
		<NPN output>
		NPN open-collector transistor
		▪Maximum sink current: 100mA
		▪Applied voltage: 30V DC or less (between output and 0V)
		▪Residual voltage: 1V or less (at 100mA sink current)
		  0.4V or less (at 16mA sink current)
		<PNP output>
		PNP open-collector transistor
		▪Maximum source current: 100mA
		▪Applied voltage: 30V DC or less (between output and ＋V)
		▪Residual voltage: 1V or less (at 100mA source current)
		  0.4V or less (at 16mA source current)

	Output operation	Light-ON / Dark-ON, selectable by switch
	Short-circuit protection	Incorporated (restored automatically)
Response time		500 μs or less
Operation indicator		Orange LED (lights up when the output is ON)
Stability indicator		Green LED (lights up under stable light received condition or stable dark condition)
Timer function		Approx. 2ms fixed OFF-delay timer, switchable either effective or ineffective
Ambient temperature		0 to ＋55°C (No dew condensation), Storage: － 10 to ＋70°C
Material		Enclosure: ABS, Stainless steel (SUS301), Lens: Acrylic
Cable		0.15mm² 5-core cabtyre cable, 300mm long
Weight		75g approx.

Notes: 1) In case of 8 inch or less wafers, the wafer pitch orientation flat or the surface condition may affect the sensing.
2) Polished wafers, etc., which have a sharp edge cannot be detected since they do not reflect the light in the light receiving direction.

DIMENSIONS (Unit: mm)

80.6
70
2-φ4.5 mounting holes
50
34
Beam-receiving part
Beam-emitting part
Beam-receiving part
12
18.3
φ4.2 cable, 300mm long

I/O CIRCUIT DIAGRAMS

NPN output

Color code
Sensor circuit
D
Zᴅ₂
Tr₂
Tr₁
Zᴅ₁
(Brown) ＋V
(Black) Output
Load
100mA max.
(Pink) Ext.light emission control input
(Violet) Ext. sensitivity selection input
(Blue) 0V
※1
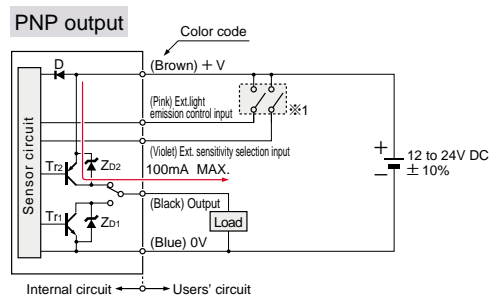12 to 24V DC ± 10%
Internal circuit ←→ Users' circuit

Symbols... D: Reverse supply polarity protection diode
Zᴅ₁, Zᴅ₂: Surge absorption zener diode
Tr₁: NPN output transistor
Tr₂: PNP output transistor

※1
Non-voltage contact or NPN open-collector transistor
or
▪ External light emission control input
0 to 3V, or 9V to ＋V (26.4V max.): Emission halted
Open, or 4 to 8V: Emission
▪ External sensitivity selection input
0 to 3V, or 9V to ＋V (26.4V max.): Input ON
Open, or 4 to 8V: Input OFF

PNP output

Color code
Sensor circuit
D
Tr₂
Tr₁
Zᴅ₂
Zᴅ₁
(Brown) ＋V
(Pink) Ext.light emission control input
(Violet) Ext. sensitivity selection input
100mA MAX.
(Black) Output
Load
(Blue) 0V
※1
12 to 24V DC ± 10%
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Open, or 4 to 8V: Input OFF

PRECAUTIONS FOR PROPER USE

Mounting

▪ Set the distance between the sensor detection surface and the wafer edge to be 45mm and mount the sensor so that sensing is done at an angle of 12.5° with respect to the wafer.

Top-view

45mm
Mounting angle 12.5°
Sensor axis
Wafer center axis
Spot position
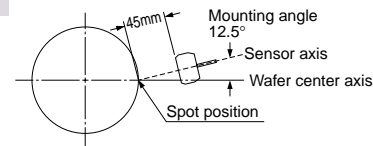
Note: If the wafer center axis and the sensor axis lie along a straight line, detection is not possible. Always mount the sensor at an angle to the wafer.

SUNX

All information is subject to change without prior notice.

http://www.sunx.co.jp/